

Docket No. 217612US2SDIV

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Hideo ANDO, et al.

SERIAL NO: 10/058,091

GAU: 2615

FILING DATE: January 29, 2002

EXAMINER: TRAN, T.

FOR: INFORMATION RECORDING METHOD AND INFORMATION REPRODUCING METHOD

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

ASSISTANT COMMISSIONER FOR PATENTS
WASHINGTON, D.C. 20231

SIR:

Applicant(s) wish to disclose the following information.

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REFERENCES

- ☒ The applicant(s) wish to make of record the 13 references listed on the attached form PTO-1449, cited in the attached Explanation of Circumstances Concerning Accelerated Examination for Japanese Patent No. 1998-133832 (filed in the Japanese Patent Office June 20, 2002). Copies of the cited references (with English translations) are attached, as are English translations for said Explanations. In addition, English translations of abstracts of 3 Japanese references previously made of record in parent application 09/651,295 are filed herewith.
- ☐ A check is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- ☐ Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- ☐ A check is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- ☐ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

- ☒ Please charge any additional fees for the papers being filed herewith and for which no check is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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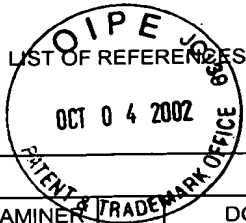
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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 217612US2S DIV		SERIAL NO. 10/058,091	
<div style="text-align: center;">  </div>				APPLICANT Hideo ANDO, et al.			
				FILING DATE January 29, 2002		GROUP 2615	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA	5,778,142	7Jul98	TAIRA, et al.			
	AB	5,915,067	22Jun99	NONOMURA, et al.			
	AC	5,999,696	7Dec99	TSUGA, et al.			
	AD	5,999,698	7Dec99	NAKAI, et al.			
	AE	6,088,507	11Jul00	YAMAUCHI, et al.			
	AF	6,094,414	25Jul00	TAIRA, et al.			
	AG	6,112,011	29Aug00	HISATOMI			
	AH	6,198,874 B1	6Mar01	KANESHIGE, et al.			
	AI	6,222,806	24Apr01	MORI, et al.			
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	JP 8-263969	11Oct96	JAPAN	x		
	AP	JP 60-236163	22Nov85	JAPAN (English Abstract of Japanese Patent)			x
	AQ	JP 58-088978	27May83	JAPAN (English Abstract of Japanese Patent)			x
	AR	JP 02-206820	16Aug90	JAPAN (English Abstract of Japanese Patent)			x
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 1998-133832 (with English translation)					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner					Date Considered		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.